

Search Notes

Application No.

10/622,544

Examiner

Blaise L Mouttet

Applicant(s)

HIRAYAMA, NOBUYUKI

Art Unit

2853

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|------------------|------------|----------|
| 347 | 12,57-59, 145 | 11/16/2004 | BM |
| 347 | 180-182 | 11/16/2004 | BM |
| 400 | 120.05 | 11/16/2004 | BM |
| 400 | 120.06 | 11/16/2004 | BM |
| 257 | 202,204 | 11/16/2004 | BM |
| 257 | 206 | 11/16/2004 | BM |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|--------------------------------------|----------|------------|----------|
| 347 | 12,57-59 | 11/16/2004 | BM |
| 347 | 145 | 11/16/2004 | BM |
| 347 | 180-182 | 11/16/2004 | BM |
| 400/120.05-120.06 257/202,204,206 | | 11/16/2004 | BM |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|------------|------|
| East text search | 11/16/2004 | BM |
| Consulted Mike Brooke (Primary class 347), Stephen Meier (SPE 347, former semiconductor examiner). | 11/16/2004 | BM |
| Consulted Mike Shingleton (Primary examiner, semiconductors) | 11/16/2004 | BM |
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